

Docket Number: 081468-0307331

PATENT APPLICATION

Client Reference: P-1774.000-US



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re the Application of

HELMAR VAN SANTEN, et al.

Group Art Unit: 2851

Application No.: 10/743,271

Examiner: Hung Nguyen

Filed: December 23, 2003

Confirmation No.: 4441

For: LITHOGRAPHIC APPARATUS AND DEVICE MANUFACTURING METHOD

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents

P. O. Box 1450

Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR 1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. One copy of each non-U.S. reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom. Applicant respectfully requests the Examiner return an initialed copy of the enclosed Form PTO-1449 to Applicant with the next Office communication to indicate that the references have been considered, per MPEP § 609.

This Information Disclosure Statement is being filed with a Request for Continued Examination. No certification or fee is required.

Respectfully Submitted,

PILLSBURY WINTHROP SHAW PITTMAN LLP

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Sheet 1 of 1

Form PTO-1449 (REV. 1/06) US Dept. of Commerce PATENT & TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				ATTY DOCKET NO. 124084.01	APPLICATION NO. New U.S. Patent Application	
				APPLICANT(S) Masahiro NEI et al.		
				FILING DATE June 23, 2006	GROUP	
U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Name		
	1	2005/0134815 A1	06-23-2005	Van Santen et al.		
FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
OTHER DOCUMENTS						
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)				
EXAMINER					DATE CONSIDERED	
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						

Date: June 23, 2006

FORM PTO-1449 (modified)
 To: U.S. Department of Commerce
 (PW FORM PAT-1449)
 Patent and Trademark Office



Atty. Dkt. No.	M#	Client Ref.
081468	0307331	P-1774.000-US
Applicant: VAN SANTEN et al.		
Appln. No. 10/743,271		
Filing Date: December 23, 2003		
Examiner: Hung Nguyen		Group Art Unit: 2851

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Date: July 31, 2007

Page **1** of **4**

U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
AR	2005/0231694 A1	10/2005	KOLESNYCHENKO et al.			
BR	2005/0217703 A1	10/2005	O'DONNELL			
CR	2005/0217137 A1	10/2005	SMITH et al.			
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ER	2005/0190455 A1	09/2005	ROSTALSKI et al.			
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GR	2005/0134815 A1	06/2005	VAN SANTEN et al.			
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IR	2005/0110973 A1	05/2005	STREEFKERK et al.			
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KR	2005/0100745 A1	05/2005	LIN et al.			
LR	2005/0094116 A1	05/2005	FLAGELLO et al.			
MR	2005/0084794 A1	04/2005	MEAGLEY et al.			
NR	2005/0073670 A1	04/2005	CARROLL			
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PR	2005/0046934 A1	03/2005	HO et al.			
QR	2005/0037269 A1	02/2005	LEVINSON			

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	Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
					Enclosed	No	Enclosed	No
RR	WO 2005/062128 A2	07/2005	WIPO	LYONS et al.				
SR	WO 2005/054955 A2	06/2005	WIPO	STREEFKERK et al.				
TR	WO 2005/054953 A2	06/2005	WIPO	GELLRICH et al.				
UR	WO 2005/034174 A2	04/2005	WIPO	CAROLL				
VR	WO 2005/024517 A2	03/2005	WIPO	POON et al.				
WR	WO 2005/024325 A2	03/2005	WIPO	HO et al.				
XR	WO 2005/022266 A2	03/2005	WIPO	PAWLOSKI et al.				
YR	WO 2005/019935 A2	03/2005	WIPO	PHAN et al.				
ZR	WO 2005/017625 A2	02/2005	WIPO	LEVINSON				
AAP	WO 2005/015283 A1	02/2005	WIPO	MANN et al.				
BBP	WO 2005/013008 A2	02/2005	WIPO	LEVINSON				
CCP	WO 2005/008339 A2	01/2005	WIPO	VAN DER NET et al.				

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

DD	United States Office Action issued for U.S. Patent Application No. 11/473,147, dated March 20, 2007.	
EEF	Information Disclosure Statement for U.S. Patent Application No. 11/473,147, filed June 23, 2006.	

Examiner	Date Considered:
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FORM PTO-1449 (modified) To: U.S. Department of Commerce (PW FORM PAT-1449) Patent and Trademark Office				Atty. Dkt. No.	M#	Client Ref.
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Applicant: VAN SANTEN et al.		
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	AR	2005/0036213 A1	02/2005	MANN et al.			
	BR	2005/0036184 A1	02/2005	YEO et al.			
	CR	2005/0036183 A1	02/2005	YEO et al.			
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	LR	2004/0227923 A1	11/2004	FLAGELLO et al.			
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						Enclosed	No	Enclosed	No
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	PR	WO 2005/003864 A2	01/2005	WIPO	HEMKER et al.				
	QR	WO 2005/001432 A2	01/2005	WIPO	KUNZ et al.				
	RR	WO 2004/095135 A2	11/2004	WIPO	NOVAK				
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	TR	WO 2004/093159 A2	10/2004	WIPO	COON et al.				
	UR	WO 2004/093130 A2	10/2004	WIPO	HAZELTON et al.				
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	XR	WO 2004/090634 A2	10/2004	WIPO	HAZELTON et al.				
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	ZR	WO 2004/090577 A2	10/2004	WIPO	BINNARD				
	AAR	WO 2004/081666 A1	09/2004	WIPO	ROLLAND et al.				
	BBR	WO 2004/077154 A2	09/2004	WIPO	BABI-ALI et al.				

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CCR	
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Page **3** of **4**

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NR	EP 0 834 773 A2	04/1998	Europe	SUWA				
OR	JP A 10-154659	06/1998	Japan	SUWA		X		X
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QR	JP A 06-181157	06/1994	Japan	UMEDA et al.		X		
RR	JP A 06-168866	06/1994	Japan	TAKAHASHI		X		
SR	JP A 05-304072	11/1993	Japan	YANAGISAWA		X		
TR	JP A 5-62877	03/1993	Japan	SHINOHARA		X		
UR	JP A 59-19912	02/1984	Japan	KAWAMURA et al.		X		
VR	JP A 57-153433	09/1982	Japan	TAKANASHI et al.		X		
WR								

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Page 4 of 4

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FFR	2006/0023182	02/2006	NOVAL et al.			
GGR						
HHR						
IIR						
JJR						
KKR						

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					Enclosed	No	Enclosed	No
LLR								
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RRR								
SSR								
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